


Search Notes 	Application/Control No. 10758863	Applicant(s)/Patent Under Reexamination STASZEWSKI ET AL.
	Examiner Flores, Leon	Art Unit 2611

SEARCHED			
Class	Subclass	Date	Examiner
375	224, 226, 375, 376	3/22/2007	LF
327	141, 147, 156	3/22/2007	LF
455	423, 425	3/12/2008	LF
375	224, 226, 227, 371, 373, 375, 376	7/17/2011	LF
455	260, 516	7/17/2011	LF
327	147, 156	7/17/2011	LF

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted with SPE Chieh Fan in regards to the patentability of claim 1 & 32	3/22/2007	LF
Consulted with SPE David Payne in regards to the patentability of the claims.	3/26/2007	LF
Checked for double patenting.	3/22/2007	LF
Consulted with SPE David Payne in regards to the amendments.	9/10/2007	LF
Consulted with SPE David Payne in regards to the AF.	11/28/2007	LF
Consulted with SPE David Payne in regards to the references used to reject the claims.	3/19/2008	LF
Consulted with SPE David Payne in regards to the arguments.	12/19/2008	LF
Consulted with SPE David Payne in regards to the new ground of rejection.	9/10/2009	LF
Searched in EAST.	7/17/2011	LF

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/L. F./ Examiner.Art Unit 2611	
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